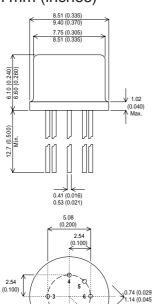




#### **MECHANICAL DATA**

Dimensions in mm (inches)



### TO-77 PACKAGE (MO - 002AF)

**Underside View** 

PIN 1 - Collector 1 PIN 4 - Emitter 2 PIN 2 - Base 1 PIN 5 - Base 2 PIN 3 - Emitter 1 PIN 6 - Collector 2

# **DUAL NPN PLANAR TRANSISTORS IN TO77 PACKAGE**

## **Applications**

- Differential Amplifiers
- High Gain, Low Noise Audio Amplifiers
- Low Level Flip Flops
- Transducer Signal Conditioner Amplifiers

## **ABSOLUTE MAXIMUM RATINGS**

	$(T_{amb} = 25^{\circ}C \text{ unless otherwise stated})$		EACH SIDE	TOTAL DEVICE	
$V_{CBO}$	Collector – Base Voltage		60V		
$V_{CEO}$	Collector – Emitter Voltage		60V		
$V_{EBO}$	Emitter – Base Voltage		6V		
$I_{\mathbb{C}}$	Continuous Collector Current		30mA		
$P_{D}$	Total Device Dissipation	$T_{AMB} = 25^{\circ}C$	300mW	500mW	
		Derate above 25°C	1.72mW / °C	2.86W / °C	
$P_{D}$	Total Device Dissipation	$T_C = 25^{\circ}C$	750mW	1.5W	
		Derate above 25°C	4.3mW / °C	8.6mW / °C	
$T_{STG}$	Storage Temperature Range		−65 to 200°C		
$T_L$	Lead temperature (Soldering, 10 sec.)		300°C		

Semelab PIc reserves the right to change test conditions, parameter limits and package dimensions without notice. Information furnished by Semelab is believed to be both accurate and reliable at the time of going to press. However Semelab assumes no responsibility for any errors or omissions discovered in its use. Semelab encourages customers to verify that datasheets are current before placing orders.

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# **ELECTRICAL CHARACTERISTICS** (T<sub>amb</sub> = 25°C unless otherwise stated)

	Parameter	Test Conditions 1		Min.	Тур.	Max.	Unit	
INDIVIDUAL TRANSISTOR CHARACTERISTICS								
V <sub>(BR)CBO</sub>	Collector – Base Breakdown Voltage	$I_C = 10\mu A$	I <sub>E</sub> = 0	60				
V <sub>(BR)CEO*</sub>	Collector – Emitter Breakdown Voltage	$I_C = 10mA$	$I_B = 0$	60			] V	
V <sub>(BR)EBO</sub>	Emitter – Base Breakdown Voltage	$I_E = 10\mu A$	I <sub>C</sub> = 0	6			1	
I <sub>CBO</sub>	Collector Cut-off Current	V <sub>CB</sub> = 45V	I <sub>E</sub> = 0			2	nA	
			T <sub>A</sub> = 150°C			10	μΑ	
I <sub>CEO</sub>	Collector Cut-off Current	$V_{CE} = 5V$	I <sub>B</sub> = 0			2	nA	
I <sub>EBO</sub>	Emitter Cut-off Current	$V_{EB} = 5V$	I <sub>C</sub> = 0			2	IIA	
h <sub>FE</sub>	DC Current Gain	$V_{CE} = 5V$	$I_C = 10\mu A$	60		240		
			$T_A = -55^{\circ}C$	15			 	
		V <sub>CE</sub> = 5V	$I_{C} = 100 \mu A$	100				
		V <sub>CE</sub> = 5V	$I_C = 1mA$	150				
V <sub>BE</sub>	Base – Emitter Voltage	V <sub>CE</sub> = 5V	$I_{C} = 100 \mu A$			0.70	V	
V <sub>CE(sat)</sub>	Collector – Emitter Saturation Voltage	I <sub>B</sub> = 100μA	$I_C = 1mA$			0.35	1	
h <sub>ib</sub>	Small Signal Common – Base		I <sub>C</sub> = 1mA	0.5		32	Ω	
	Input Impedance	f = 1kHz		25				
h <sub>ob</sub>	Small Signal Common – Base	$V_{CB} = 5V$	I <sub>C</sub> = 1mA			1	μmho	
	Output Admittance	f = 1kHz						
h <sub>fe</sub>	Small Signal Common – Base	V <sub>CE</sub> = 5V	I <sub>C</sub> = 500μA					
	Current Gain	f = 20MHz		3			-	
C <sub>obo</sub>	Common – Base Open Circuit	V <sub>CB</sub> = 5V	I <sub>E</sub> = 0					
	Output Capacitance	f = 140kHz to 1MHz				6	pF	

<sup>\*</sup> Pulse Test:  $t_p = 300 \mu s$ ,  $\delta \le 1\%$ .

Parameter		Test Conditions		Min.	Тур.	Max.	Unit	
TRANSISTOR MATCHING CHARACTERISTICS								
h <sub>FE1</sub>	Static Forward Current Gain	$V_{CE} = 5V$	$I_{C} = 100 \mu A$	0.9		1		
h <sub>FE2</sub>	Balance Ratio	See Note 2.		0.9		'		
V <sub>BE1</sub> – V <sub>BE2</sub>	Base – Emitter Voltage Differential	$V_{CE} = 5V$	I <sub>C</sub> = 100μA			3	mV	
	base – Efficier voltage billerential	$V_{CE} = 5V$	$I_C = 10\mu A$ to 1mA			5		
$ \Delta(V_{BE1} - V_{BE2})\Delta T_A $		$V_{CE} = 5V$	$I_{C} = 100 \mu A$			0.8		
	Base – Emitter Voltage Differential	$T_{A1} = +25^{\circ}C$	$T_{A2} = -55^{\circ}C$			0.6	. mV	
	Change With Temperature	V <sub>CE</sub> = 5V	$I_C = 100 \mu A$ $T_{A2} = +125 ^{\circ} C$			1		
		$T_{A1} = +25^{\circ}C$	$T_{A2} = +125$ °C		ı	'		

- **NOTES**1) Terminals not under test are open circuited under all test conditions.
- 2) The lower of the two readings is taken as  $h_{\text{FE1}}$ .

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